Product data sheet

1. General description

Silicon Carbide MOSFET in a TO3PF plastic package, designed for high frequency, high efficiency systems.



2. Features and benefits

- Optimized for fly-back topologies
- 15V/0V gate-source voltage compatible with fly-back controllers
- 100% UIS Tested
- Controllable dV/dt for optimized EMI
- Reduced cooling requirements
- Enlarge creepage distance
- RoHS compliant

3. Applications

- Auxiliary Power Supplies
- Switch Mode Power Supplies
- Solar Inverter
- Frequency converter
- Industrial power supply

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Notes		Values		Unit
Absolute	maximum rating		'				
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C			1700		V
I _D	drain current	V _{GS} = 18 V; T _{mb} = 25 °C			4.6		А
P _{tot}	total power dissipation	T _{mb} = 25 °C			34		W
T _j	junction temperature				-55 to 17	5	°C
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics						
$R_{\text{DS(on)}}$	drain-source on-state resistance	$V_{GS} = 15 \text{ V}; I_D = 1 \text{ A}; T_j = 25 ^{\circ}\text{C}$		-	1000	-	mΩ
Dynamic	characteristics						
Q _{G(tot)}	total gate charge	I _D = 2 A; V _{DS} = 1200 V; V _{GS} = 0 V/18 V;		-	12	-	nC
Q_{GD}	gate-drain charge	$T_j = 25 ^{\circ}\text{C}$		-	5	-	nC
Source-d	Irain diode						
Q _r	recovered charge	I_{SD} = 1 A; di/dt = 500 A/ μ s; V_{DS} = 400 V; T_{j} = 25 °C		-	38	-	nC

5. Pinning information

Table 2. Pinning information

Symbol	Description	Simplified outline	Graphic symbol
G	gate	mb Ol	D
D	drain		
S	source	<u> </u>	$_{G}$
n.c.	mounting base; isolated		
			sym300 S
		ŲŲ	
	G D S	G gate D drain S source	G gate D drain S source

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number		Small packing quantity	Package version	Package issue date
WNSC2M1K0170J	TO3PF	WNSC2M1K0170JQ	Tube	30	SOT1293	16-Mar-2006

7. Marking

Table 4. Marking codes

Type number	Marking codes
WNSC2M1K0170J	WNSC2M 1K0170J

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Vaules	Unit
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		1700	V
$V_{\rm GS,max}$	gate-source voltage			-10 to 22	V
$V_{GS,op}$	gate-source voltage			-5 to 18	V
P_{tot}	total power dissipation	T _{mb} = 25 °C		34	W
I _D	drain current	V _{GS} = 18 V; T _{mb} = 25 °C		4.6	А
		V _{GS} = 18 V; T _{mb} = 100 °C		3.3	А
I _{DM}	peak drain current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 ^{\circ}C$		10	А
E _{as}	single pulse drain-to- source avalanche	$I_{AS} = 7 \text{ A}; L = 1 \text{ mH}; V_{DD} = 100 \text{ V};$ $T_{j(init)} = 25 \text{ °C}$		24.5	mJ
T _{stg}	storage temperature			-55 to 175	°C
T _j	junction temperature			-55 to 175	°C
$T_{sld(M)}$	peak soldering temperature			260	°C

Note: Device is ESD sensitive. Handling precautions are recommanded.

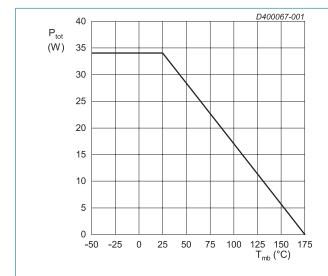


Fig. 1. Total power dissipation as a function of mounting base temperature; maximum values

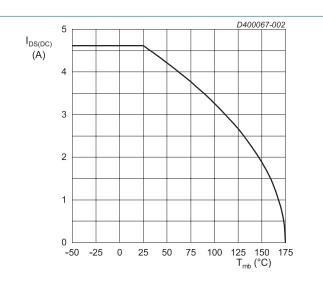


Fig. 2. Continuous Drain Current as a function of mounting base temperature

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base			-	4.4	-	K/W
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient	in free air		-	50	-	K/W

Note: It is recommended that a metal washer is inserted between screw head and mounting tab. Do not use self-tapping screws.

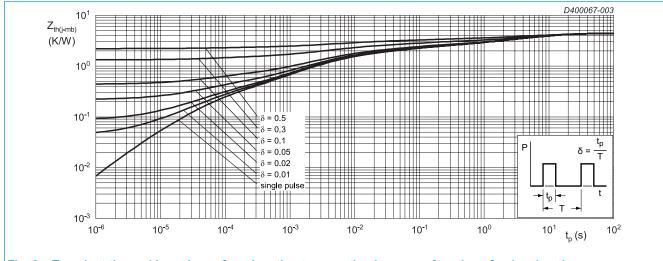


Fig. 3. Transient thermal impedance from junction to mounting base as a function of pulse duration

10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics				1		
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 100 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^{\circ}C$		1700	-	-	V
00(111)	gate-source threshold	$I_D = 0.8 \text{ mA}; V_{DS} = 10 \text{ V}; T_j = 25 \text{ °C}$		2.3	3.2	4.2	V
	voltage	I _D = 0.8 mA; V _{DS} = 10 V; T _j = 150 °C		-	2.4	-	V
I _{DSS}	drain leakage current	V _{DS} = 1700 V; V _{GS} = 0 V; T _j = 25 °C		-	0.1	10	μΑ
		V _{DS} = 1700 V; V _{GS} = 0 V; T _j = 150 °C		-	1	-	μΑ
I _{GSS}	gate leakage current	V _{GS} = 18 V; V _{DS} = 0 V; T _j = 25 °C		-	10	100	nA
		V _{GS} = -10 V; V _{DS} = 0 V; T _j = 25 °C		-	10	100	nA
R _{DS(on)}	drain-source on-state	V _{GS} = 15 V; I _D = 1 A; T _j = 25 °C		-	1000	-	mΩ
	resistance	V _{GS} = 18 V; I _D = 1 A; T _j = 25 °C		-	750	1000	mΩ
		V _{GS} = 18 V; I _D = 1 A; T _j = 150 °C		-	1050	-	mΩ
R _G	gate resistance	f = 1 MHz; T _j = 25 °C		-	16	-	Ω
g _{fs}	transconductance	V _{DS} = 10 V; I _D = 1 A; T _j = 25 °C		-	0.5	-	S
Dynamic	characteristics						
Q _{G(tot)}	total gate charge	$I_D = 2 \text{ A}; V_{DS} = 1200 \text{ V}; V_{GS} = 0 \text{ V}/18 \text{ V};$		-	12	-	nC
Q _{GS}	gate-source charge	T _j = 25 °C		-	3.8	-	nC
Q_{GD}	gate-drain charge			-	5	-	nC
C _{iss}	input capacitance	V _{DS} = 1000 V; V _{GS} = 0 V; f = 1 MHz;		-	225	-	pF
C _{oss}	output capacitance	T _j = 25 °C		-	15	-	pF
C _{rss}	reverse transfer capacitance			-	2.8	-	pF
E _{oss}	Coss stored energy			-	7.5	-	μJ
$t_{d(on)}$	turn-on delay time	V _{DS} = 1000 V; V _{GS} = -3 V/18 V;		-	5.6	-	ns
t _r	rise time	$R_{G(ext)} = 5.1 \Omega$; $I_D = 2 A$; $L = 4.8 \text{ mH}$; $T_i = 25 \text{ °C}$		-	18	-	ns
$t_{\text{d(off)}}$	turn-off delay time			-	7.8	-	ns
t _f	fall time			-	60	-	ns
E _{on}	turn-on energy (Body Diode FWD)			-	57	-	μJ
E _{off}	turn-off energy (Body Diode FWD)			-	11	-	μJ
Source-d	rain diode						1
V_{SD}	source-drain voltage	V _{GS} = 0 V; I _{SD} = 1 A; T _j = 25 °C		-	3.9	-	V
		V _{GS} = 0 V; I _{SD} = 1 A; T _j = 150 °C		-	3.4	-	V
t _{rr}	reverse recovery time	I _{SD} = 1 A; di/dt = 500 A/μs; V _{DS} = 400 V;		-	36	-	ns
Q _r	recovered charge	T _j = 25 °C		-	38	-	nC
I _{rrm}	reverse recovery current			_	1.8	-	Α

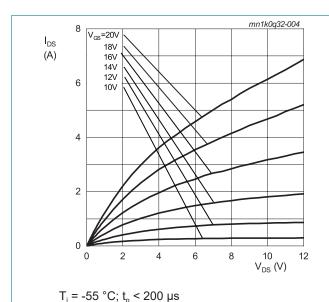
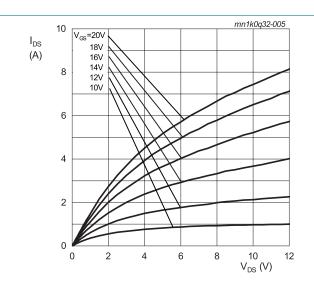
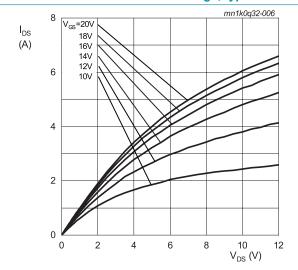


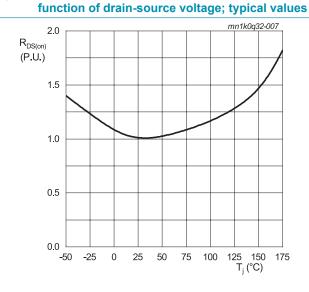
Fig. 4. Output characteristics; drain current as a function of drain-source voltage; typical values



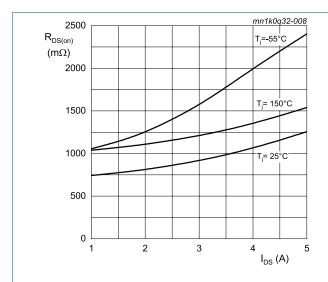
 T_j = 25 °C; t_p < 200 µs Fig. 5. Output characteristics; drain current as a



 $T_{j} = 150~^{\circ}\text{C}; \, t_{p} < 200~\mu\text{s}$ Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values

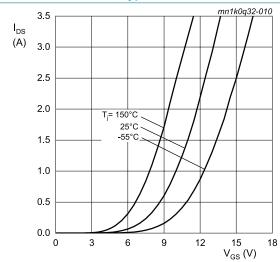


 $I_{DS} = 1 \text{ A; } V_{GS} = 18 \text{ V; } t_p < 200 \text{ } \mu \text{s}$ Fig. 7. Normalized drain-source on-state resistance as a function of junction temperature

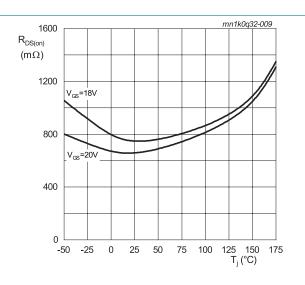


 V_{GS} = 18 V; t_p < 200 μ s

Fig. 8. Drain-source on-state resistance as a function of drain current; typical values

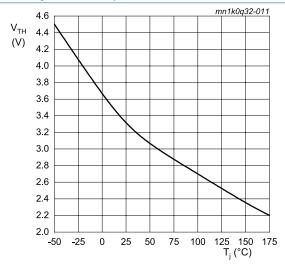


 V_{DS} = 10 V; t_p < 200 μs Fig. 10. Transfer characteristics; drain current as a function of gate-source voltage; typical values



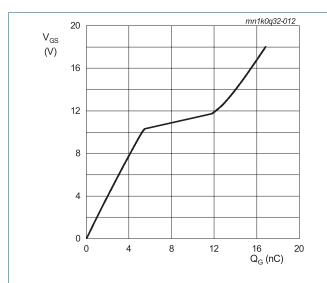
 $I_{DS} = 1 \text{ A}; t_p < 200 \text{ }\mu\text{s}$

Fig. 9. Drain-source on-state resistance as a function of junction temperature



 $V_{DS} = 10 \text{ V}; I_{DS} = 0.8 \text{ mA}$

Fig. 11. Threshold voltage as a function of junction temperature



I_{DS} = 2 A; I_{GS} = 0.1 mA; V_{DS} = 1200 V; T_j = 25 °C Fig. 12. Gate-source voltage as a function of gate charge; typical values

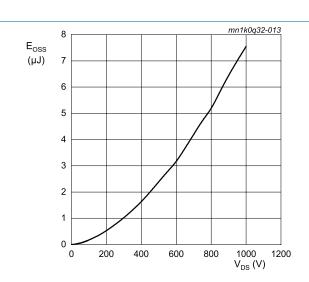
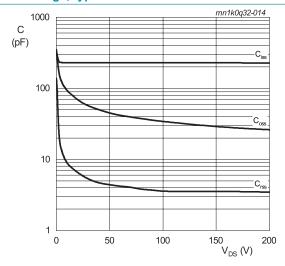
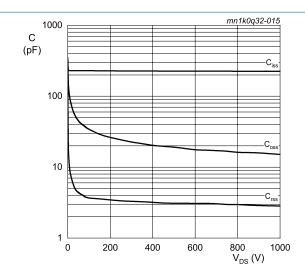


Fig. 13. Output capacitor stored energy as a function of drain-source voltage



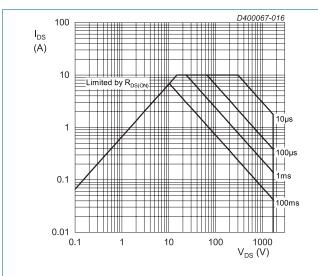
T_j = 25 °C; V_{AC} = 25 mV; f = 1 MHz Fig. 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

 $V_{DS} = 0 - 200 \text{ V}$



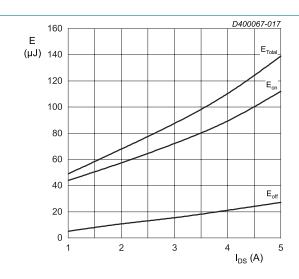
 $V_{DS} = 0 - 1000 \text{ V}$ $T_j = 25 \text{ °C; } V_{AC} = 25 \text{ mV; } f = 1 \text{ MHz}$

Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



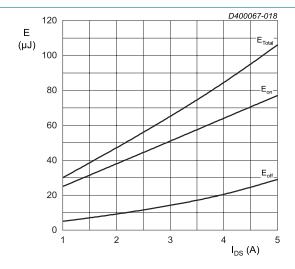
 $T_j = 25 \text{ °C}; D = 0$ Parameter: t_p

Fig. 16. Forward bias safe operating area



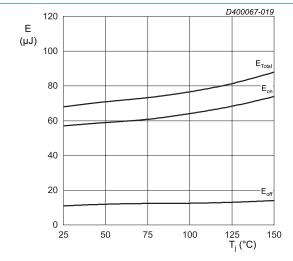
 T_{j} = 25 °C; V_{DD} = 1000 V; $R_{G(ext)}$ = 5.1 $\Omega;$ V_{GS} = -3 V/18 V; FWD = WNSC2M1K0170B7 L = 4.8 mH

Fig. 17. Clamped Inductive Switching Energy as a function of drain current



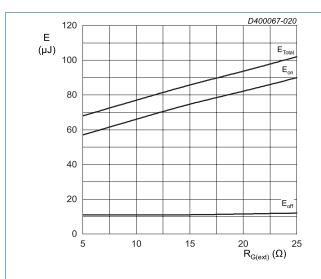
 T_{j} = 25 °C; V_{DD} = 1200 V; $R_{G(ext)}$ = 5.1 $\Omega;$ V_{GS} = -3 V/18 V; FWD = WNSC2M1K0170J L = 4.8 mH

Fig. 18. Clamped Inductive Switching Energy as a function of drain current



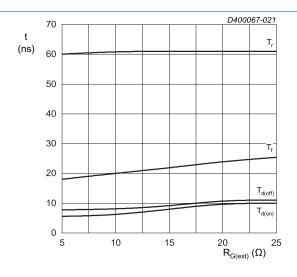
 I_{DS} = 2 A; V_{DD} = 1000 V; $R_{G(ext)}$ = 5.1 $\Omega;$ V_{GS} = -3 V/18 V; FWD = WNSC2M1K0170J L = 4.8 mH

Fig. 19. Clamped Inductive Switching Energy as a function of junction temperature



 $\rm T_{j}$ = 25 °C; $\rm V_{DD}$ = 1000 V; $\rm I_{DS}$ = 2 A; $\rm V_{GS}$ = -3 V/18 V FWD = WNSC2M1K0170J; L = 4.8 mH

Fig. 20. Clamped Inductive Switching Energy as a function of external gate resistance



 T_{j} = 25 °C; V_{DD} = 1000 V; I_{DS} = 2 A; V_{GS} = -3 V/18 V FWD = WNSC2M1K0170J; L = 4.8 mH

Fig. 21. Switching time as a function of external gate resistance

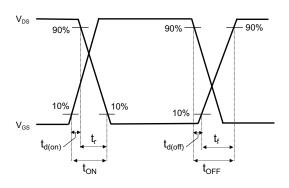
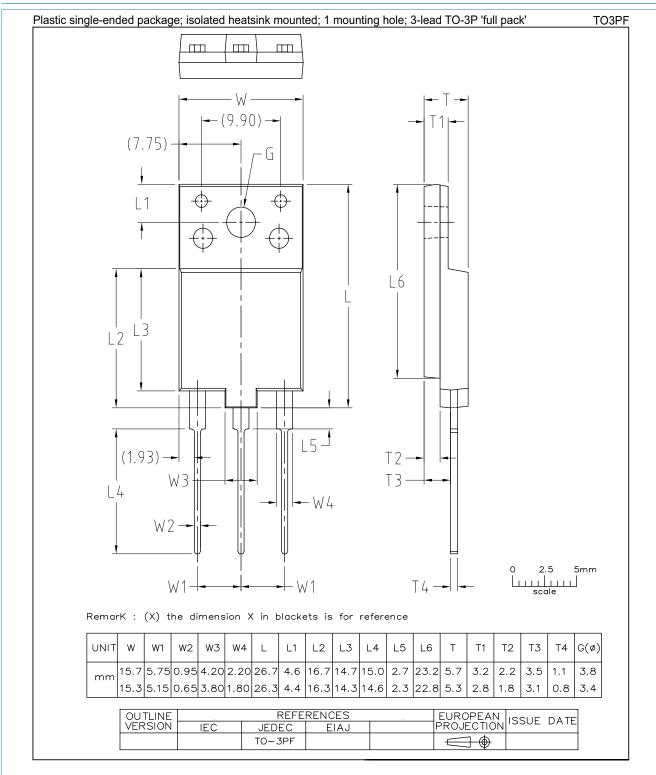


Fig. 22. Switching time definition

11. Package outline



12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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